

Search Notes

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Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

HIROSE ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
438	181, 197, 287	6/2/2006	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search history printout	6/2/2006	TT
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